

<b>Notice of References Cited</b>	Application/Control No. 10/038,344		Applicant(s)/Patent Under Reexamination ZHANG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0095327 A1	07-2002	Zumel et al.	705/10
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/31607	06-2000	PCT	Gefen et al.	G06F
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**NON-PATENT DOCUMENTS**

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